Notice of References Cited

Application/Control No.

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Examiner

John A. Hevey

Applicant(s)/Patent Under
Reexamination
TAKAGAWA ET AL.

Art Unit
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,458,286 B1	10-2002	Takagawa et al.	252/62.62
*	В	US-6,627,103 B2	09-2003	Yasuhara et al.	252/62.62
*	С	US-2005/0167632 A1	08-2005	Fukuchi et al.	252/062.62
*	D	US-2006/0045839 A1	03-2006	Takagawa et al.	423/594.1
	Ε	US-			•
	F	US-			
	G	US-			
	н	US-			
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Ρ					
	σ					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

	NON-I ATENI DOCUMENTO					
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U	JP06-310321(Machine translation), Matsutani et al., 04/1994				
	٧	JP11-003813 (Machine translation), Kono et al., 06/1999				
	w					
	x					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.